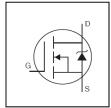




HEXFET® Power MOSFET

Application

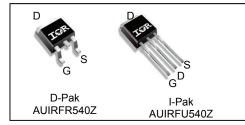
- Automatic Voltage Regulator (AVR)
- Solenoid Injection
- Body Control
- Low Power Automotive Applications



V _{DSS}		100V
R _{DS(on)}	typ.	22.5mΩ
	max.	28.5mΩ
I _D		35A

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.



G	D	S
Gate	Drain	Source

Bass nort number	Dookogo Typo	Backage Type Standard Pack		Orderable Part Number
Base part number	Package Type	Form	Quantity	Orderable Part Number
AUIRFU540Z	I-Pak	Tube	75	AUIRFU540Z
ALUDED5407	D. Dok	Tube	75	AUIRFR540Z
AUIRFR540Z	D-Pak	Tape and Reel Left	3000	AUIRFR540ZTRL

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless

•	3	. ,	
Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	35	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	25	Α
I _{DM}	Pulsed Drain Current ①	140	
P _D @T _C = 25°C	Maximum Power Dissipation	91	W
	Linear Derating Factor	0.61	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) ②	39	
E _{AS} (Tested)	Single Pulse Avalanche Energy Tested Value ®	75	mJ
I _{AR}	Avalanche Current ①	Con Fig 15 16 120 12h	Α
E _{AR}	Repetitive Avalanche Energy ©	See Fig.15,16, 12a, 12b	mJ
T_J	Operating Junction and	FF to 1 17F	
T_{STG}	Storage Temperature Range	-55 to + 175	°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ®		1.64	
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount) ⑦		50	°C/W
$R_{\theta JA}$	Junction-to-Ambient		110	

HEXFET® is a registered trademark of Infineon.

2017-10-03

^{*}Qualification standards can be found at www.infineon.com



Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	100			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.092		V/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		22.5	28.5	mΩ	V _{GS} = 10V, I _D = 21A ③
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}$, $I_D = 50\mu A$
gfs	Forward Trans conductance	28			S	$V_{DS} = 25V, I_{D} = 21A$ ③
	Drain-to-Source Leakage Current			20		$V_{DS} = 100V, V_{GS} = 0V$
IDSS	Drain-to-Source Leakage Current			250	μA	$V_{DS} = 100V, V_{GS} = 0V, T_{J} = 125$ °C
	Gate-to-Source Forward Leakage			200	n ^	V _{GS} = 20V
I _{GSS}	Gate-to-Source Reverse Leakage			-200		V _{GS} = -20V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

		-	-		
Total Gate Charge		39	59		I _D = 21A
Gate-to-Source Charge		11		nC	$V_{DS} = 50V$
Gate-to-Drain Charge		12			V _{GS} = 10V3
Turn-On Delay Time		14			$V_{DD} = 50V$
Rise Time		42		20	I _D = 21A
Turn-Off Delay Time		43		115	$R_G = 13\Omega$
Fall Time		34			V _{GS} = 10V3
Internal Drain Inductance		4.5			Between lead, 6mm (0.25in.)
Internal Source Inductance		7.5			from package and center of die contact
Input Capacitance		1690			$V_{GS} = 0V$
Output Capacitance		180			$V_{DS} = 25V$
Reverse Transfer Capacitance		100		nΕ	f = 1.0MHz
Output Capacitance		720		рΓ	$V_{GS} = 0V$, $V_{DS} = 1.0V$ $f = 1.0MHz$
Output Capacitance		110			$V_{GS} = 0V$, $V_{DS} = 80V$ $f = 1.0MHz$
Effective Output Capacitance		190			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 80V \oplus$
	Gate-to-Source Charge Gate-to-Drain Charge Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Internal Drain Inductance Internal Source Inductance Input Capacitance Output Capacitance Reverse Transfer Capacitance Output Capacitance Output Capacitance Output Capacitance Output Capacitance	Gate-to-Source Charge —— Gate-to-Drain Charge —— Turn-On Delay Time —— Rise Time —— Turn-Off Delay Time —— Fall Time —— Internal Drain Inductance —— Input Capacitance —— Output Capacitance —— Reverse Transfer Capacitance —— Output Capacitance ——	Gate-to-Source Charge — 11 Gate-to-Drain Charge — 12 Turn-On Delay Time — 14 Rise Time — 42 Turn-Off Delay Time — 43 Fall Time — 34 Internal Drain Inductance — 4.5 Internal Source Inductance — 7.5 Input Capacitance — 1690 Output Capacitance — 100 Output Capacitance — 100 Output Capacitance — 720 Output Capacitance — 110	Gate-to-Source Charge — 11 — Gate-to-Drain Charge — 12 — Turn-On Delay Time — 14 — Rise Time — 42 — Turn-Off Delay Time — 43 — Fall Time — 34 — Internal Drain Inductance — 4.5 — Internal Source Inductance — 7.5 — Input Capacitance — 1690 — Output Capacitance — 180 — Reverse Transfer Capacitance — 100 — Output Capacitance — 720 — Output Capacitance — 110 —	Gate-to-Source Charge — 11 — nC Gate-to-Drain Charge — 12 — Turn-On Delay Time — 14 — Rise Time — 42 — Turn-Off Delay Time — 43 — Fall Time — 34 — Internal Drain Inductance — 4.5 — Input Capacitance Inductance — 7.5 — Input Capacitance — 1690 — Output Capacitance — 100 — Output Capacitance — 720 — Output Capacitance — 110 —

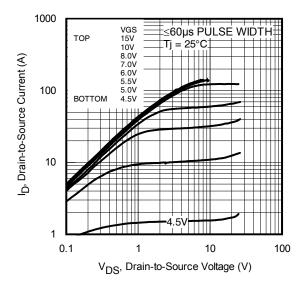
Diode Characteristics

Diodo oii							
	Parameter	Min.	Тур.	Max.	Units	Conditions	
ı	Continuous Source Current			35		MOSFET symbol	
Is	(Body Diode)	dy Diode)	35		showing the		
	Pulsed Source Current			140	Α	integral reverse	
I _{SM}	(Body Diode) ①			- 140		p-n junction diode.	
V_{SD}	Diode Forward Voltage			1.3	٧	$T_J = 25^{\circ}C, I_S = 21A, V_{GS} = 0V$ ③	
t _{rr}	Reverse Recovery Time		32	48	ns	$T_J = 25^{\circ}C$, $I_F = 21A$, $V_{DD} = 50V$	
Q _{rr}	Reverse Recovery Charge		40	60	nC	di/dt = 100A/µs③	
t _{on}	Forward Turn-On Time	Intrinsi	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)				

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Limited by T_{Jmax} , starting $T_J = 25$ °C, L = 0.17mH, $R_G = 25\Omega$, $I_{AS} = 21$ A, $V_{GS} = 10$ V. Part not recommended for use above this value.
- \oplus C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}
- © Limited by T_{Jmax}, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- © This value determined from sample failure population, 100% tested to this value in production.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994





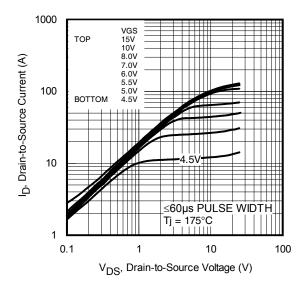
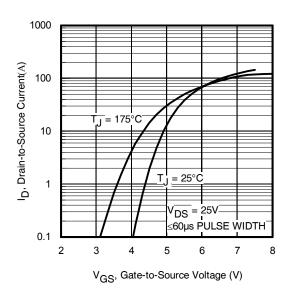


Fig. 1 Typical Output Characteristics

Fig. 2 Typical Output Characteristics





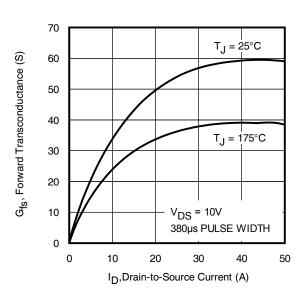


Fig. 4 Typical Forward Trans conductance Vs. Drain Current



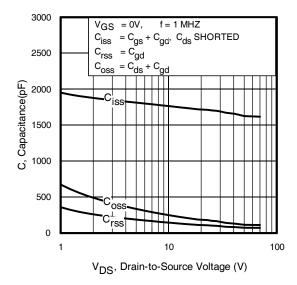


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

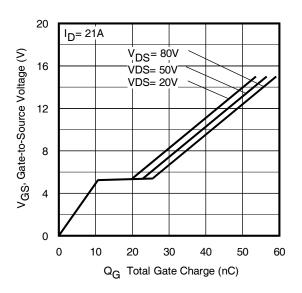


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

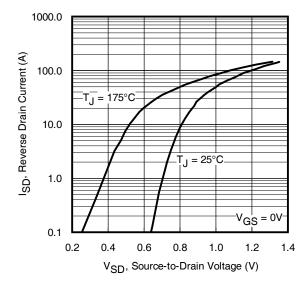


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

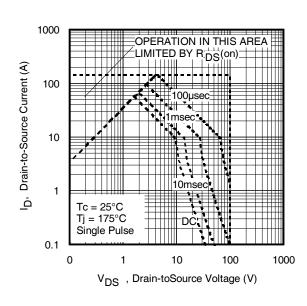
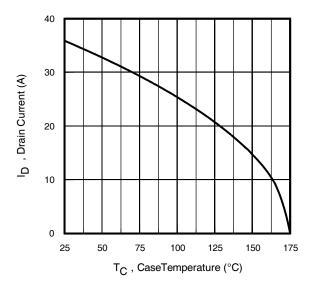


Fig 8. Maximum Safe Operating Area





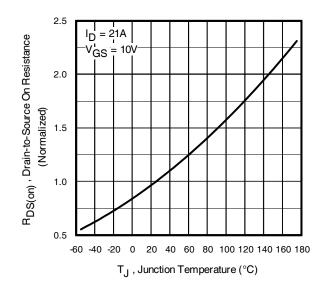


Fig 9. Maximum Drain Current Vs. Case Temperature

Fig 10. Normalized On-Resistance Vs. Temperature

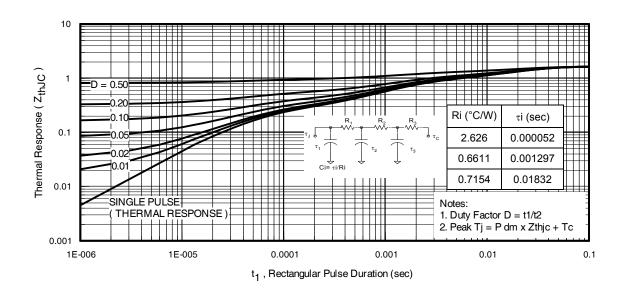


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



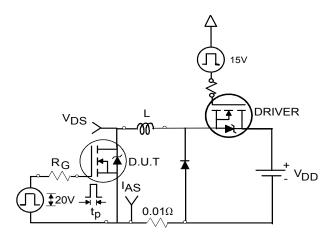


Fig 12a. Unclamped Inductive Test Circuit

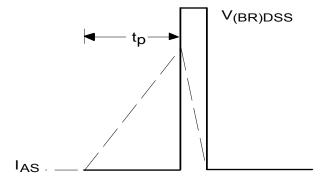


Fig 12b. Unclamped Inductive Waveforms

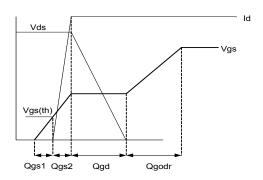


Fig 13a. Gate Charge Waveform

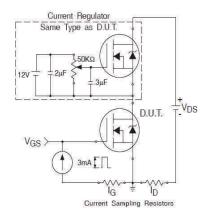


Fig 13b. Gate Charge Test Circuit

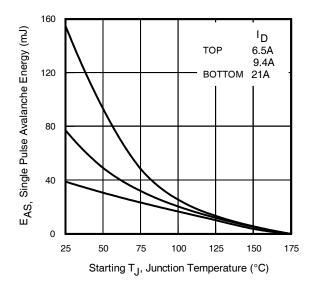


Fig 12c. Maximum Avalanche Energy vs. Drain Current

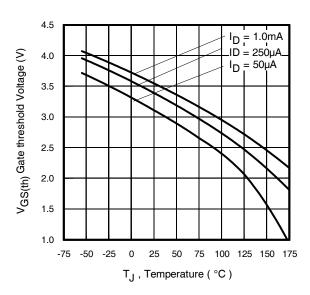


Fig 14. Threshold Voltage Vs. Temperature

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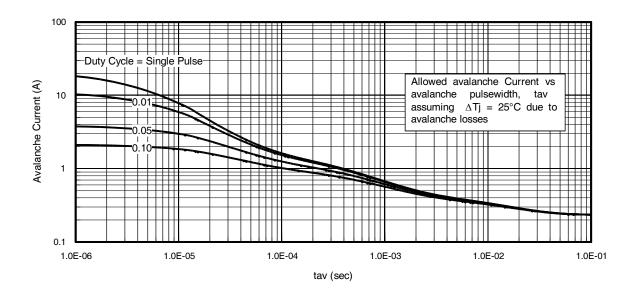


Fig 15. Typical Avalanche Current Vs. Pulse width

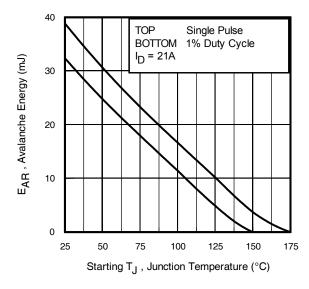


Fig 16. Maximum Avalanche Energy Vs. Temperature

Notes on Repetitive Avalanche Curves , Figures 15, 16:

(For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption:
 Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{imax}. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as T_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 15, 16).

tav = Average time in avalanche.

D = Duty cycle in avalanche = tav ·f

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \Delta T / \; Z_{thJC} \\ I_{av} &= 2\Delta T / \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$



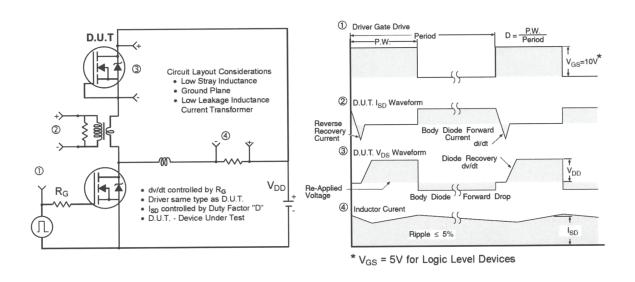


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

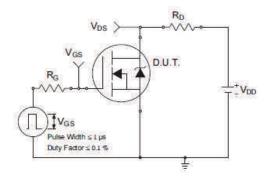


Fig 18a. Switching Time Test Circuit

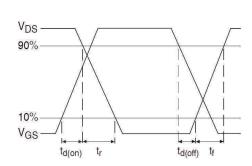
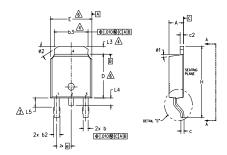


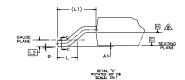
Fig 18b. Switching Time Waveforms

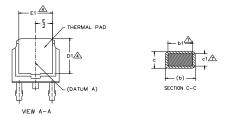


D-Pak (TO-252AA) Package Outline (Dimensions are shown in millimeters (inches))









NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- 3- LEAD DIMENSION UNCONTROLLED IN L5.
- A- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.- SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- 6- DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- A- DIMENSION b1 & c1 APPLIED TO BASE METAL ONLY.
- ATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

S							
Y M		DIMEN	SIONS		N		
B	MILLIMETERS		INC	INCHES			
L	MIN.	MAX.	MIN.	MAX.	O T E S		
Α	2.18	2.39	.086	.094			
A1	-	0.13	-	.005			
b	0.64	0.89	.025	.035			
ь1	0.65	0.79	.025	.031	7		
b2	0.76	1.14	.030	.045			
b3	4.95	5.46	.195	.215	4		
С	0.46	0.61	.018	.024			
c1	0.41	0.56	.016	.022	7		
c2	0.46	0.89	.018	.035			
D	5.97	6.22	.235	.245	6		
D1	5.21	-	.205	-	4		
Ε	6.35	6.73	.250	.265	6		
E1	4.32	-	.170	-	4		
е	2.29 BSC		.090	BSC			
Н	9.40	10.41	.370	.410			
L	1.40	1.78	.055	.070			
L1	2.74	BSC	.108 REF.				
L2	0.51	BSC	.020	BSC			
L3	0.89	1.27	.035	.050	4		
L4	-	1.02	-	.040			
L5	1.14	1.52	.045	.060	3		
ø	0.	10°	0,	10°			
ø1	0,	15*	0,	15*			
ø2	25*	35*	25*	35*			

LEAD ASSIGNMENTS

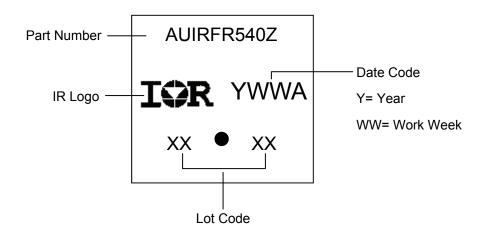
HEXFET

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

IGBT & CoPAK

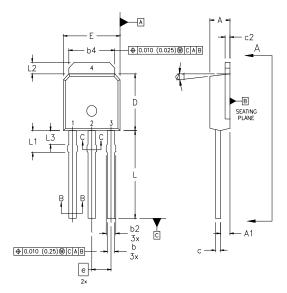
- 1.- GATE
- 2.- COLLECTOR 3.- EMITTER
- 3.- EMITTER 4.- COLLECTOR

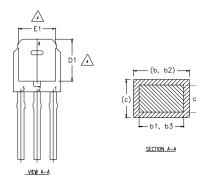
D-Pak (TO-252AA) Part Marking Information





I-Pak (TO-251AA) Package Outline (Dimensions are shown in millimeters (inches)





NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994.
- DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

 DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

 DIMENSION D & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH SHALL NOT EXCEED 0.005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY. 3
- THERMAL PAD CONTOUR OPTION WITHIN DIMENSION 64, L2, E1 & D1.
- LEAD DIMENSION UNCONTROLLED IN L3.
- DIMENSION 61, 63 APPLY TO BASE METAL ONLY. OUTLINE CONFORMS TO JEDEC OUTLINE TO-251AA.
- CONTROLLING DIMENSION : INCHES.

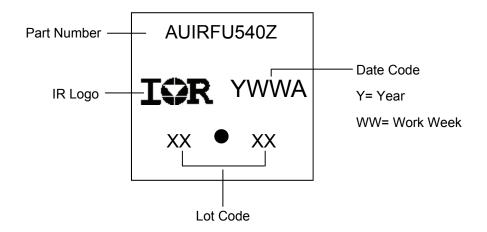
LEAD ASSIGNMENTS

H	1	Ξ	Х	F	Ε	Ţ

1.- GATE 2.- DRAIN 3.- SOURCE 4.- DRAIN

		DIMENSIONS					
SYMBOL	MILLIM	ETERS	INCHES				
	MIN.	MAX.	MIN.	MAX.	NOTES		
Α	2.18	2.39	0.086	.094			
A1	0.89	1.14	0.035	0.045			
b	0.64	0.89	0.025	0.035			
ь1	0.64	0.79	0.025	0.031	4		
b2	0.76	1.14	0.030	0.045			
b3	0.76	1.04	0.030	0.041			
b4	5.00	5.46	0.195	0.215	4		
С	0.46	0.61	0.018	0.024			
c1	0.41	0.56	0.016	0.022			
c2	.046	0.86	0.018	0.035			
D	5.97	6.22	0.235	0.245	3, 4		
D1	5.21	-	0.205	-	4		
E	6.35	6.73	0.250	0.265	3, 4		
E1	4.32	-	0.170	-	4		
е	2.	29	0.090	BSC			
L	8.89	9.60	0.350	0.380			
L1	1.91	2.29	0.075	0.090			
L2	0.89	1.27	0.035	0.050	4		
L3	1,14	1.52	0.045	0.060	5		
ø1	0*	15*	0*	15*			

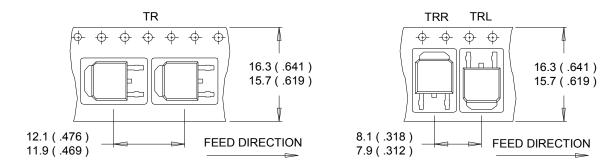
I-Pak (TO-251AA) Part Marking Information



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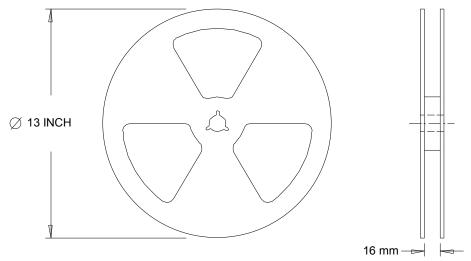


D-Pak (TO-252AA) Tape & Reel Information (Dimensions are shown in millimeters (inches))



NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES:

1. OUTLINE CONFORMS TO EIA-481.



Qualification Information

		Automotive (per AEC-Q101)				
		Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.				
		D-Pak	MSL1			
Woisture	Moisture Sensitivity Level		IVISL I			
	Machine Model	Class M2 (+/-200V) [†]				
	Machine Model		AEC-Q101-002			
FOD	Livers on Dody Model	Class H1B (+/-1000V) [†]				
ESD	Human Body Model	AEC-Q101-001				
	Channed Davis Medal	Class C5 (+/-2000V) [†]				
	Charged Device Model	AEC-Q101-005				
RoHS Compliant		Yes				

[†] Highest passing voltage.

Revision History

Date	Comments
06/06/2014	Updated part number by the pictures of the parts to AU nomenclature on page 1.
12/02/2015	 Updated datasheet with corporate template Corrected ordering table on page 1. Corrected typo RthJA (PCB Mount) from "40°C/W" to "50°C/W" on page 1
10/03/2017	Corrected typo error on package outline and part marking on page 9 and 10.

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